

Notice of References Cited	Application/Control No. 10/585,755	Applicant(s)/Patent Under Reexamination PARK ET AL.	
	Examiner YUWEN PAN	Art Unit 2618	Page 1 of 1

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*	A	US-2008/0261650	10-2008	Piriyapoksombut et al.	455/552.1
*	B	US-7,272,413	09-2007	Yu, Jae-Wook	455/552.1
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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